

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

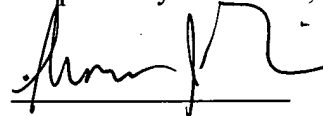
In re Application of)
Thomas L. Obert et al.) GAU:
Ser. No. (filed concurrently)) Examiner:
Filed: (concurrently))
For: APPARATUS AND METHOD USING WAVEFRONT)
PHASE MEASUREMENTS TO DETERMINE)
GEOMETRICAL RELATIONSHIPS)

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Applicant submits herewith six English-language references that may be material to the examination of this application. Please consider these references and make them of record.

Respectfully submitted,



4/2/04

Thomas Finn

Reg. No. 48,066

Attorney for Applicant

INFORMATION DISCLOSURE CITATION
(Substitute for Form PTO FB A820)
Page 1 of 1

Serial No. Filed:

Applicant: Thomas L. Obert et al.

GAU: Examiner:

Attorney Docket No. PD-02W054

US PATENT DOCUMENTS

Examiner's Initials	Document No.	Date	Name	Class	Subclass	Filing Date
	4,366,483	12/82	Hagedon et al.			
	4,524,359	6/85	Champagne			
	6,252,558	6/01	Brown et al.			
	6,407,806	6/02	Fujisawa et al.			

OTHER DOCUMENTS

Examiner's Initials	Publication
	Kai Chang, ed., Handbook of Microwave and Optical Components, Vol. 1, page 153, John Wiley & Sons., Inc., 1989
	Merrill I. Skolnik, ed., Radar Handbook, second edition, pages 3/36-3/37, McGraw Hill, 1990.

Examiner's Signature

Date Considered